



SHEET 1 OF 1

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.  
217416US2SDIVSERIAL NO.  
10/058,079

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT  
Shuichi HISATOMI, et al.FILING DATE  
January 29, 2002GROUP  
~~2015~~ 2621

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<i>6-07</i>	AO	11-187354	07/09/1999	JAPAN		X
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

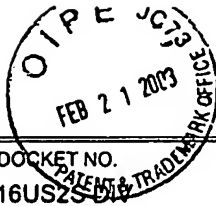
## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attachedExaminer *CHRISTOPHER DUNAKU*Date Considered *7/28/06*

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 217416US-2S DIV		SERIAL NO. 10/058,079	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Shuichi HISATOMI et al.			
				FILING DATE January 29, 2002		GROUP <del>261</del> 2621	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>680</i>	AA	5,798,995	25 Aug 1998	Fukushima et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO						
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	AW						
	AX						
	AY						
	AZ						
Examiner <i>CHRISTOPHER ONYAKU</i>					Date Considered <i>7/28/06</i>		
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.  
217416US25-019SERIAL NO.  
10/058,079

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT  
Shuichi HISATOMI, et al.FILING DATE  
January 29, 2002GROUP  
~~2619~~ 2621

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

RECEIVED

FEB 24 2003

Technology Center 2600

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<i>See</i>	AO	JP 8-130700	21May96	JAPAN (with English Abstract)		x
<i>See</i>	AP	JP 11-176137	02July99	JAPAN (with English Abstract)		x
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	Notification of Reasons for Rejection re: Japanese Patent Application No.: 2001-270250 (with English translation)				
	AX					
	AY					
	AZ					<input type="checkbox"/> Additional References sheet(s) attached

Examiner *CHRISTOPHER ONIYAKU*Date Considered *7/28/06*

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

APR 29 2004

SHEET 1 OF 1

PTO 1449  
(MAY 2002)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.  
217416US2S DIVSERIAL NO.  
10/058,079

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT  
Shuichi HISATOMI, et al.FILING DATE  
January 29, 2002GROUP  
~~2616~~ 2621

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA					
	AB					
	AC					
	AD					
	AE					
	AF					
	AG					
	AH					
	AI					
	AJ					
	AK					
	AL					
	AM					
	AN					

RECEIVED

MAY 05 2004

Technology Center 2600

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
				YES	NO
600	AO 9-284705	10/31/1997	JAPAN		X
	AP				
	AQ				
	AR				
	AS				
	AT				
	AU				
	AV				

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attachedExaminer *CHRISTOPHER ONYAKU*Date Considered *7/28/06*

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

BEST AVAILABLE COPY

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

217416US-2S DIV

SERIAL NO. 10/058079

New Div. Appln.

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Shuichi HISATOMI, et al.

FILING DATE

1/29/02

GROUP

2621

HEREWITH

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
600	AO	6-319125	11/15/94	JAPAN		
600	AP	6-89549	03/29/94	JAPAN		X
	AQ					X
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

Examiner CHRISTOPHER DNUAKU

Date Considered 7/28/06

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

KET # 217416US-2S DIV

10/058079

# Notice of References Cited

Application No.  
New Divisional

Applicant(s)

Shuichi HISATOMI et al

Examiner  
To be assigned  
C. ONUAKU

Group Art Unit  
Unknown  
2621

Page 1 of 3

## U.S. PATENT DOCUMENTS

	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS
A	6,016,381	1/00	Taira et al	386	9597
B	6,112,010	8/00	Koyama	386	126
C	4,685,003	8/87	Westland	386	52
D					
E					
F					
G					
H					
I					
J					
K					
L					
M					

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUBCLASS
N						
O						
P						
Q						
R						
S						
T						

## NON-PATENT DOCUMENTS

	DOCUMENT (Including Author, Title, Source, and Pertinent Pages)	DATE
U		
V		
W		
X		

\* A copy of this reference is not being furnished with this Office action.  
(See Manual of Patent Examining Procedure, Section 707.05(a).)

U.S. Patent and Trademark Office  
PTO-892 (Rev. 9-95)

Notice of References Cited

Part of Paper No. 6

7/28/06

CHRISTOPHER ONUAKU

01/29/02

DOCKET # 217416US-2S DIV

997 U.S. PTO  
10/058079  
01/29/02

# Notice of References Cited

Application No.  
10/058,079  
New Div. Appln.

Applicant(s)

Hisatomi et al

Examiner

C. ONUAKU

Group Art Unit

2621

Page 1 of 1

## U.S. PATENT DOCUMENTS

	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS
DA	4,685,003	8/87	Westland	388	52
DB	5,621,840	4/97	Kawamura et al	388	68
DC	5,905,841	5/99	Peters et al	388	62
D					
E					
F					
G					
H					
I					
J					
K					
L					
M					

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUBCLASS
N						
O						
P						
Q						
R						
S						
T						

## NON-PATENT DOCUMENTS

	DOCUMENT (Including Author, Title, Source, and Pertinent Pages)	DATE
U		
V		
W		
X		

CHRISTOPHER ONUAKU

7/28/06